

<b>Notice of References Cited</b>	Application/Control No. 10/682,399		Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner LOAN TRUONG		Art Unit 2114	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,243,824	06-2001	Kakuta et al.	714/3
*	B	US-2004/0059855	03-2004	Yang et al.	710/260
*	C	US-5,586,247	12-1996	Yoshifuji et al.	714/2
*	D	US-6,973,549	12-2005	Testardi, Richard	711/150
*	E	US-2004/0148479	07-2004	Patel et al.	711/163
*	F	US-6,732,124	05-2004	Koseki et al.	707/202
*	G	US-2004/0260894	12-2004	Keohane et al.	711/162
*	H	US-6,898,600	05-2005	Fruchtman et al.	707/10
*	I	US-6,973,455	12-2005	Vahalia et al.	707/8
*	J	US-6,988,171	01-2006	Beardsley et al.	711/144
*	K	US-6,880,051	04-2005	Timpanaro-Perrotta, Michael C.	711/162
*	L	US-6,851,073	02-2005	Cabrera et al.	714/15
*	M	US-6,694,447	02-2004	Leach et al.	714/6

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/682,399		Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner LOAN TRUONG		Art Unit 2114	Page 2 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,618,794	09-2003	Sicola et al.	711/154
*	B	US-6,865,655	03-2005	Andersen, Bryon Scott	711/162
*	C	US-5,586,247	12-1996	Yoshifuji et al.	714/2
*	D	US-6,829,688	12-2004	Grubbs et al.	711/162
*	E	US-5,854,754	12-1998	Cabrera et al.	703/2
*	F	US-2003/0225898	12-2003	Saika et al.	709/229
*	G	US-2004/0260726	12-2004	Hrle et al.	707/104.1
*	H	US-6,865,655	03-2005	Andersen, Bryon Scott	711/162
*	I	US-6,829,688	12-2004	Grubbs et al.	711/162
*	J	US-2003/0225898	12-2003	Saika et al.	709/229
*	K	US-6,732,124	05-2004	Koseki et al.	707/202
*	L	US-5,854,754	12-1998	Cabrera et al.	703/2
*	M	US-2004/0260894	12-2004	Keohane et al.	711/162

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/682,399	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner LOAN TRUONG	Art Unit 2114	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0010287	01-2006	Kim, Han-gyoo	711/112
*	B	US-6,618,794	09-2003	Sicola et al.	711/154
*	C	US-6,543,001	04-2003	LeCrone et al.	714/6
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.